

# General purpose

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Characteristic and test conditions	Min.	Typ.	Max.	Unit
$h_{FE}$	DC Current Gain (5) $I_C = 100 \mu\text{A}$ $V_{CE} = 1\text{V}$ $I_C = 5 \text{ mA}$ $V_{CE} = 1\text{V}$ $I_C = 150 \text{ mA}$ $V_{CE} = 1\text{V}$ $I_C = 500 \text{ mA}$ $V_{CE} = 1\text{V}$	40	250	500	
$V_{BE \text{ sat}}$	Base Saturation Voltage (5) $I_C = 150 \text{ mA}$ $I_B = 15 \text{ mA}$ $I_C = 1 \text{ A}$ $I_B = 0.1 \text{ A}$	0.9	1	1.6	V
$V_{BE \text{ on}}$	Base Emitter On Voltage $I_C = 150 \text{ mA}$ $V_{CE} = 15 \text{ V}$	0.13	0.25		V
$V_{CE \text{ sat}}$	Collector Saturation Voltage (5) $I_C = 1 \text{ A}$ $I_B = 0.1 \text{ A}$	0.65	1		V
$I_{CES}$	Collector Reverse Current $V_{CE} = 50\text{V}$ $V_{EB} = 0$	0.1	10		nA
$I_{CES(150^\circ\text{C})}$	Collector Reverse Current $V_{CE} = 50\text{V}$ $V_{EB} = 0$	0.1	10		$\mu\text{A}$
$I_{EBO}$	Emitter Reverse Current $V_{EB} = 5\text{V}$ $I_C = 0$	0.1	10		nA
$BV_{CES}$	Collector to Emitter Breakdown Voltage $I_C = 1 \text{ A}$ $V_{EB} = 0$	75			V
$BV_{EBO}$	Emitter to Base Breakdown Voltage $I_E = 1 \text{ A}$ $I_C = 0$	7			V
$IV_{CEO}$	Collector to Emitter Sustaining Voltage (4 and 5) $I_C = 1 \text{ A}$ $I_B = 0$	35			V
$h_{fe}$	High Freq. Current Gain ( $f=20 \text{ MHz}$ ) $I_C = 50 \text{ mA}$ $V_{CE} = 10\text{V}$	3	4.5		
$C_{TE}$	Emitter Transition Capacitance $I_C = 0$ $V_{EB} = 0.5\text{V}$	50	80		pF
$C_{obo}$	Base Collector Capacitance $I_E = 0$ $V_{CB} = 10\text{V}$	13	20		pF
$t_{on}$	Turn On Time $I_C = 150 \text{ mA}$ $I_{B1} = 7.5 \text{ mA}$	130	200		ns
$t_{off}$	Turn Off Time $I_C = 150 \text{ mA}$ $I_{B1} = 7.5 \text{ mA}$ $I_{B2} = 7.5 \text{ mA}$	450	800		ns

### NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of  $200^\circ\text{C}$  and junction - to - case thermal resistance of  $35^\circ\text{C}/\text{W}$  (derating factor of  $28.6 \text{ mW}/^\circ\text{C}$ ); junction - to - ambient thermal resistance of  $219^\circ\text{C}/\text{W}$  (derating factor of  $4.57 \text{ mW}/^\circ\text{C}$ ).
- (4) These ratings refer to a high - current point where collector - to - emitter voltage is lowest. For more information send for SGS - AR 5.
- (5) Measured under pulse conditions: pulse length =  $300 \mu\text{sec}$ ; duty cycle = 1%.

The BFR 20 is an NPN silicon planar epitaxial transistor designed primarily for amplifier and switching applications over a wide range of voltage and current. This device features a useful beta range from  $100 \mu\text{A}$  to  $500 \text{ mA}$  and low saturation voltage permitting switching operation at 1 ampere.

## ABSOLUTE MAXIMUM RATINGS (1)

( $T_A = 25^\circ\text{C}$  unless otherwise noted)

### Voltages

Collector to Emitter (4)	$V_{CEO}$	35 V
Collector to Emitter	$V_{CES}$	75 V
Emitter to Base	$V_{EBO}$	7 V

### Temperatures

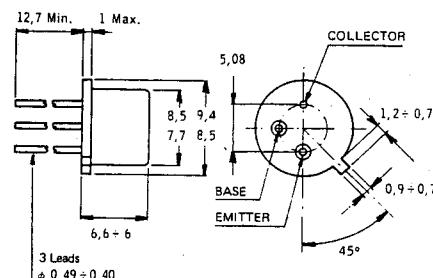
Storage Temperature	TSTG	-55°C to 200°C
Junction Temperature	$T_J$	200°C
Lead Temperature (Soldering 10 sec.)	$T_L$	260°C

### Power (2 - 3)

Dissipation at 25°C	$P_D$	5 W
Case Temperature		
Dissipation at 25°C	$P_D$	0.8 W
Ambient Temperature		

## PHYSICAL DIMENSIONS

Similar to Jedec TO-5



Note : All dimensions are in mm.

